Docket No.: 60188-770 **PATENT**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Takashi OHTSUKA, et al. : Confirmation Number:

Serial No.: Divisional of Appl. No.

09/977,310 : Group Art Unit:

Filed: March 04, 2004 : Examiner:

For: SEMICONDUCTOR DEVICE AND METHOD FOR DRIVING THE SAME

INFORMATION DISCLOSURE STATEMENT

Mail Stop Information Disclosure Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The references were cited by or submitted to the U.S. Patent and Trademark Office in parent application Serial No. <u>09/977,310</u>, filed <u>October 16, 2001</u>, which is relied upon for an

Divisional of Appl. No. 09/977,310

earlier filing date under 35 USC 120. Thus, copies of these references are not attached. 37 CFR 1.98(d).

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

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Facsimile: (202) 756-8087 **Date: March 4, 2004**

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INFORMATION DISCLOSURE · CITATION IN AN APPLICATION					ATTY. DOCKET NO. 60188-770		SERIAL NO. Divisional of Appl. No. 09/977,310				
					APPLICANT Takashi OHTSUKA	APPLICANT Takashi OHTSUKA, et al.					
(PTO-1449)					FILING DATE March 04, 2004						
				U.S. PATE	NT DOCUMENTS						
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.